



Study of the effective mass dependent charge qubit performance in voltage-tunable double quantum dot channel nanowire FETs

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- ☐ Introduction.
- □ Semiconductor qubits.
- □ Advantages and challenges of quantum dots.
- DQD generation in nanowire FET.
- Mathematical modelling.
- □ Results.
- □ Conclusions.
- □ Acknowledgements.
- □ References.

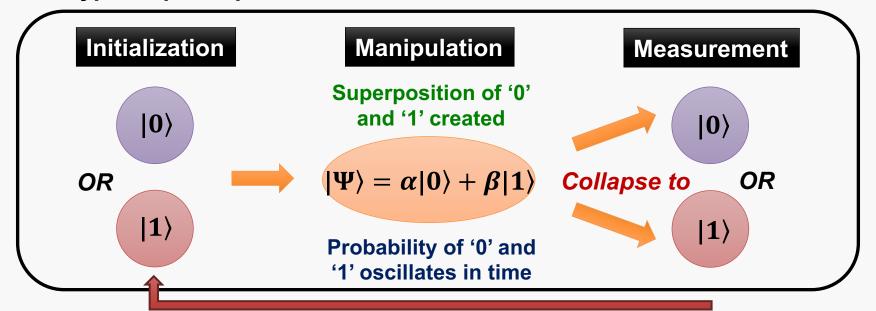


Introduction: Qubits

- ☐ Quantum analogue to the classical bit.
- \square Two-level system with basis states $|0\rangle$ and $|1\rangle$.
- \square Information is represented by a state $|\Psi\rangle$ where,

$$|\Psi
angle=lpha|0
angle+eta|1
angle$$
 Superposition

Typical qubit operation:

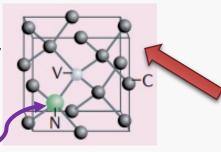




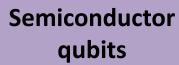
Semiconductor qubits

Color centres

Neumann et. al., *Nat. Phys.* 6, pp. 249 – 253 (2010)

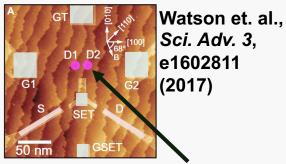


Color centres arising due to incorporation of N and Si defects into high bandgap materials, host the quantum state.

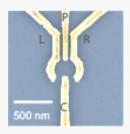




Dopant based



³¹P dopants in Si, with gate controlled quantum state.



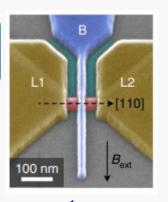
Gate-defined quantum dots

Kulesh et. al., *Phys. Rev. App. 13*, 041003 (2020)

Gate voltages create quantum dots by depleting 2D electron gas.

Quantum dots in FET architecture

Camenzind et. al., *Nat. Electron. 5*, pp. 178-183 (2021)



Gate voltage creates quantum dots in the channel.



QDs: Advantages & Challenges

Challenges:

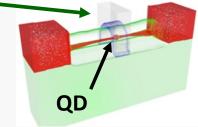
- QD sizes are limited by lithography processes, which lead to ~meV energy level spacing.
- Extremely susceptible to environmental noise.
- Operation limited to ~mK temperatures.

Advantages:

- Established technology for qubit generation.
- Fabrication process compatible with existing semiconductor processing technologies.
- Reduced complexity in operation.

Motivation for qubit generation in FET devices:

- Channel dimensions are already at quantum length scale.
- Localized gates on the channel of nanowire FETs can create quantum dots.
- Gate lengths and channel dimensions can be tuned for high temperature operation.
- > CMOS compatible technology.

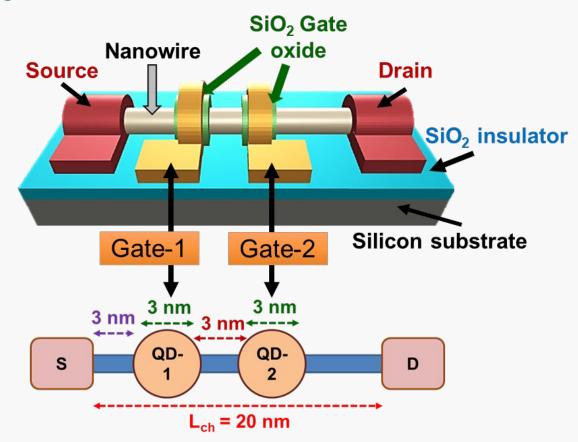


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DQD generation in NWFET

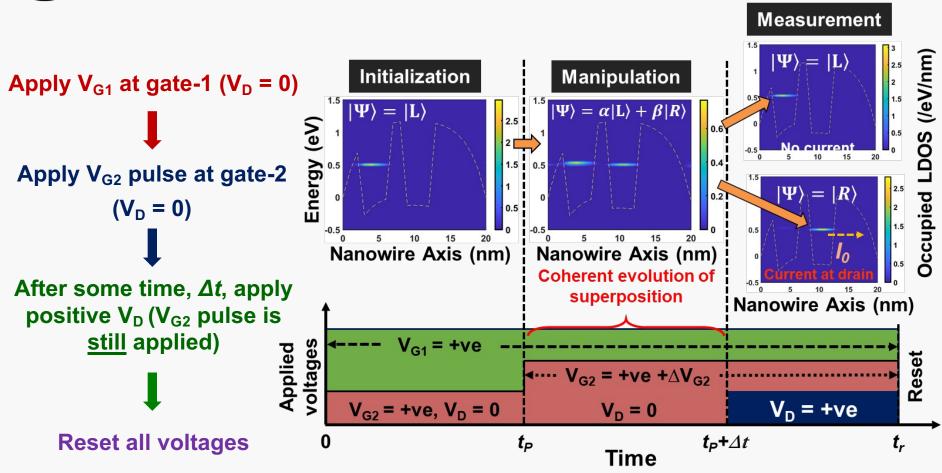
- Use localized gates to create QDs in channel of a nanowire FET.
- Gate voltages control electron population inside the QDs.
- Gate voltages also modulate inter-dot tunneling.
- Gate length and nanowire diameter control the overall QD eigenstates.



Schematic of charge qubit device in state-of-the-art nanowire FET architecture.



Scheme of charge qubit operation

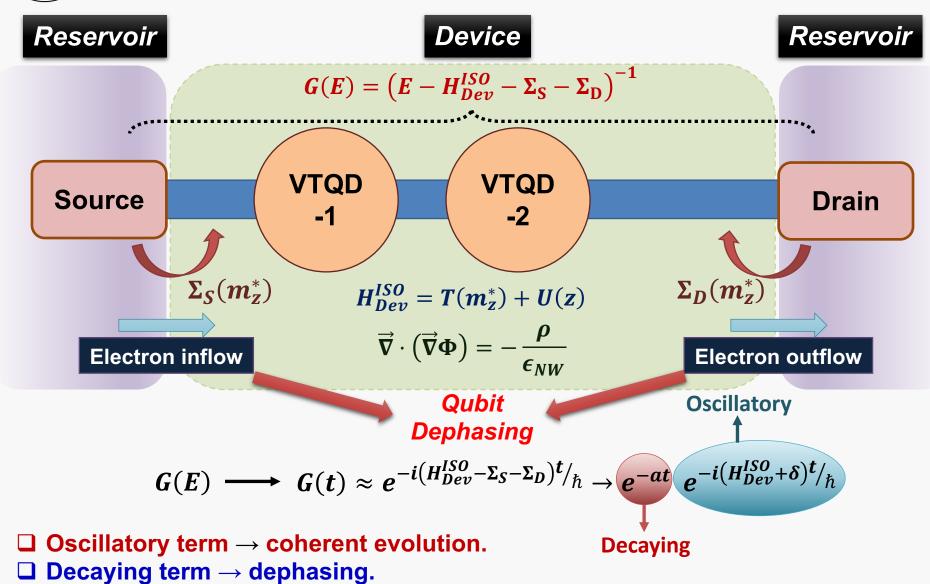


Operation scheme is similar to Gorman et. al., PRL 2005. (10.1103/PhysRevLett.95.090502)

*Positional basis: $|L\rangle$ and $|R\rangle$ are the logical qubit states! Physics remains same, the representation changes.



Mathematical Modeling: NEGF



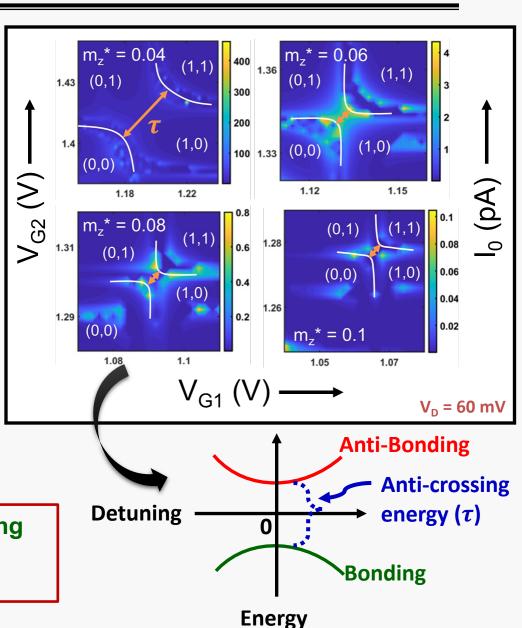
Drain bias increases 'a' \rightarrow quicker dephasing.



Results: Charge stability

- Performance predominantly depends on transport effective mass.
- Charge stability diagram denotes the charge states of the DQD.
- Anti-crossing energy is the measure of inter-dot coupling strength.
- Lower voltages are required to obtain charge stability at higher m_z^* .
- The stability diagram sharpens from hyperbolic to straight line like nature with the increase in m_z^* .

<u>High</u> effective mass → <u>low</u> tunneling probability → <u>low</u> anti-crossing energy.





Results: Bloch sphere coverage

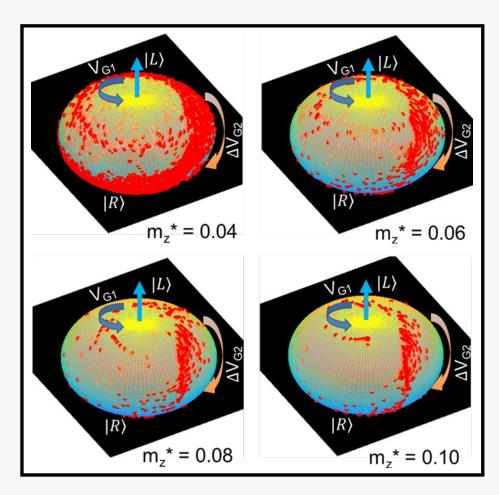
- Bloch sphere coverage indicates the achievable superpositions of |L⟩ and |R⟩.
- Higher coverage → better (more) information encoding ability.
- Coverage varies with m_z^* dependent inter-dot tunneling probability.

Superposed state:

$$|\Psi
angle = \sin(heta/2)\,|L
angle + \cos(heta/2)e^{i\phi}\,|R
angle$$

$$\Delta V_{G2} \ {
m modulates} \ heta \ V_{G1} \ {
m modulates} \ heta$$

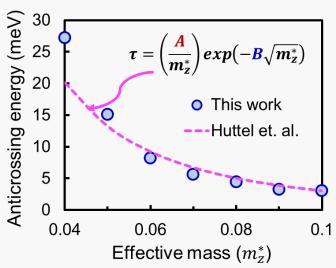
- $ightharpoonup Higher <math>m_z^*$ degrades tunneling probability \Rightarrow superposition not possible at every gate voltage combination.
- φ coverage significantly reduced!

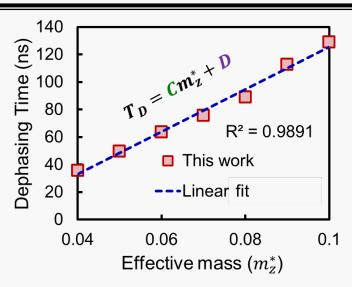


**Mathematically, θ is obtained from LDOS and ϕ is obtained from local phase of the Green's function



Results: Anti-crossing & Dephasing





- Anti-crossing energy rapidly decreases with increase in $m{m}_{m{z}}^*$.
- The expression for anti-crossing energy can be derived using WKB approach for a double quantum well/dot problem. Huttel et. al. experimentally verified it.
- This work shows agreement at high m_z^* . Difference at low m_z^* due to level broadening and band bending along channel.
- Dephasing time (T_D) boosted by increased effective mass as tunneling probability to drain is reduced.

**Increased dephasing times obtained at the cost of reduced inter-dot coupling, i.e., reduced Bloch sphere coverage

Huttel et. al. (2005, PRB)

DOI: 10.1103/PhysRevB.72.081310



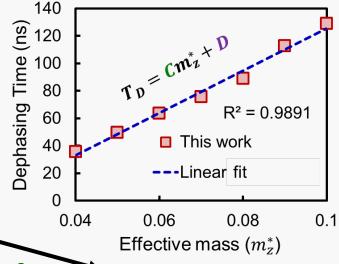
Dephasing in details...

☐ Recall the time domain Green's function...

$$G(t) = G_0 e^{-i(H_{Dev}^{ISO} - \Sigma_S - \Sigma_D)t/\hbar}$$

 Σ_S , Σ_D are complex. So,

$$G(t) \approx \left(e^{-i\left(H_{Dev}^{ISO} - Re(\Sigma_S) - Re(\Sigma_D)\right)t/\hbar}\right) \left(e^{-im(\Sigma_S + \Sigma_D)t/\hbar}\right)$$



Imaginary part of the self-energies are responsible for dephasing!

**In tight binding form, $\Sigma_D=rac{\hbar^2}{2m_z^*}(...)\Longrightarrow aarphirac{1}{m_z^*}$

See: Nag Chowdhury et. al., Adv. Quantum Technol., 2023

[10.1002/qute.202200072]

- \square Thus, $T_D = \frac{1}{a} \propto m_Z^*$
- ☐ The linear fit " $Cm_z^* + D$ " suggests that dephasing time will approach zero for some critical m_z^* value!

For more details about Σ_D , see: Nag Chowdhury et. al., J. App. Phys., 20

Nag Chowdhury et. al., J. App. Phys., 2014 [10.1063/1.4869495] Venugopal et. al., J. App. Phys., 2002 [10.1063/1.1503165]

Conclusions

- Inter-dot coupling and source/drain coupling significantly dependent on transport effective mass.
- High effective mass reduces inter-dot coupling and Bloch sphere coverage, while sharpening the charge stability diagram.
- High effective mass reduces coupling of DQD with source/drain reservoirs so as to boost dephasing time.
- However, longer dephasing times obtained at the cost of reduced inter-dot coupling and degraded Bloch sphere coverage.
- Dephasing time varies linearly with effective mass.
- Physics driven approach to anti-crossing and dephasing ensures validity of predicted results across different qubit platforms.

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THANK YOU.